


<b>Search Notes</b> 	<b>Application/Control No.</b> 10568598	<b>Applicant(s)/Patent Under Reexamination</b> ASAMURA ET AL.
	<b>Examiner</b> M. Lee	<b>Art Unit</b> 2622

SEARCHED			
Class	Subclass	Date	Examiner
348	665, 505, 506-509, 536, 537, 549,	8/15/08	ml

SEARCH NOTES		
Search Notes	Date	Examiner
east	8/15/08	ml

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/M. Lee/ Primary Examiner.Art Unit 2622
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